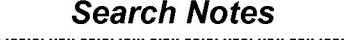


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/840,110	WEEL, MARTIN	
	Examiner	Art Unit	
	OANH DUONG	2455	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner